FAIRCHILD
SEMICONDUCTOR®

IGBT

FGA50N60LS

General Description

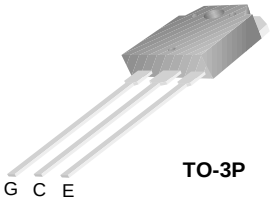
Fairchild's LS series product of Insulated Gate Bipolar Transistors (IGBTs) provides low conduction and switching losses as well as short circuit ruggedness. The LS series is especially designed for applications in medium frequencies such as switched reluctance motor controls, AC & DC motor controls, general inverters etc.

Features

- Short circuit rated 10µs @ T_C = 100°C, V_{GE} = 15V
- Low saturation voltage : $V_{CE(sat)}$ = 1.6 V @ I_C = 50A
- High input impedance
- Optimized for medium operating frequencies (1~5kHz)

Applications

Switched Reluctance Motor Controls , AC & DC motor controls, general purpose inverters,Robotics, and Servo controls



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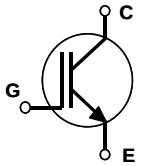

Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Description		FGA50N60LS	Units
V_{CES}	Collector-Emitter Voltage		600	V
V_{GES}	Gate-Emitter Voltage		± 20	V
I_C	Collector Current	@ T_C = 25°C	100	A
	Collector Current	@ T_C = 100°C	50	A
$I_{CM\ (1)}$	Pulsed Collector Current		150	A
T_{SC}	Short Circuit Withstand Time	@ T_C = 100°C	10	µs
P_D	Maximum Power Dissipation	@ T_C = 25°C	240	W
	Maximum Power Dissipation	@ T_C = 100°C	96	W
T_J	Operating Junction Temperature		-55 to +150	°C
T_{stg}	Storage Temperature Range		-55 to +150	°C
T_L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes :
(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	--	0.52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	--	40	°C/W

Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
Off Characteristics						
BV_{CES}	Collector-Emitter Breakdown Voltage	V_{GE} = 0V, I_C = 250uA	600	--	--	V
$\Delta B_{VCES}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	V_{GE} = 0V, I_C = 1mA	--	0.6	--	V/°C
I_{CES}	Collector Cut-Off Current	V_{CE} = V_{CES}, V_{GE} = 0V	--	--	250	uA
I_{GES}	G-E Leakage Current	V_{GE} = V_{GES}, V_{CE} = 0V	--	--	± 100	nA
On Characteristics						
$V_{GE(th)}$	G-E Threshold Voltage	I_C = 50mA, V_{CE} = V_{GE}	3.5	5.5	7.5	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	I_C = 50A, V_{GE} = 15V	--	1.6	1.8	V
		I_C = 80A, V_{GE} = 15V	--	1.96	--	V
Dynamic Characteristics						
C_{ies}	Input Capacitance	V_{CE} = 30V, V_{GE} = 0V, f = 1MHz	--	2660	--	pF
C_{oes}	Output Capacitance		--	250	--	pF
C_{res}	Reverse Transfer Capacitance		--	78	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{CC} = 300 V, I_C = 50A, R_G = 5.9Ω, V_{GE} = 15V, Inductive Load, T_C = 25°C	--	54	--	ns
t_r	Rise Time		--	96	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	146	220	ns
t_f	Fall Time		--	326	600	ns
E_{on}	Turn-On Switching Loss		--	1.1	--	mJ
E_{off}	Turn-Off Switching Loss		--	3.2	--	mJ
E_{ts}	Total Switching Loss		--	4.3	6.0	mJ
$t_{d(on)}$	Turn-On Delay Time	V_{CC} = 300 V, I_C = 50A, R_G = 5.9Ω, V_{GE} = 15V, Inductive Load, T_C = 125°C	--	56	--	ns
t_r	Rise Time		--	87	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	134	215	ns
t_f	Fall Time		--	575	880	ns
E_{on}	Turn-On Switching Loss		--	1.2	--	mJ
E_{off}	Turn-Off Switching Loss		--	5.0	--	mJ
E_{ts}	Total Switching Loss		--	6.2	8.7	mJ
T_{sc}	Short Circuit Withstand Time	V_{CC} =300 V, V_{GE} = 15V @ T_C = 100°C	10	--	--	µs
Q_g	Total Gate Charge	V_{CE} = 300 V, I_C = 50A, V_{GE} = 15V	--	167	240	nC
Q_{ge}	Gate-Emitter Charge		--	27	35	nC
Q_{gc}	Gate-Collector Charge		--	68	100	nC
L_e	Internal Emitter Inductance	Measured 5mm from PKG	--	14	--	nH

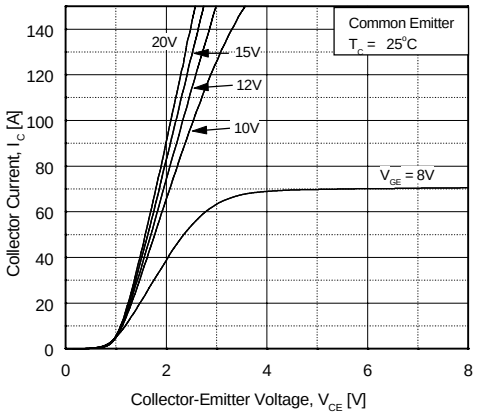

Fig 1. Typical Output Characteristics

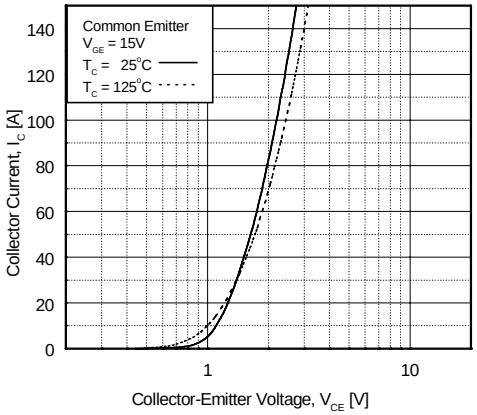

Fig 2. Typical Saturation Voltage Characteristics

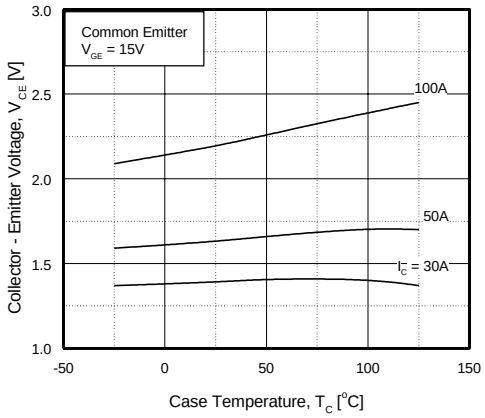

Fig 3. Saturation Voltage vs. Case Temperature at Variant Current Level

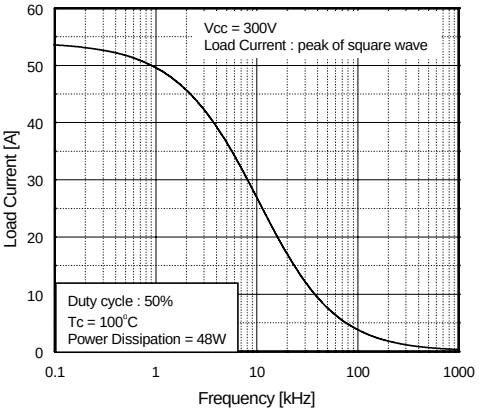

Fig 4. Load Current vs. Frequency

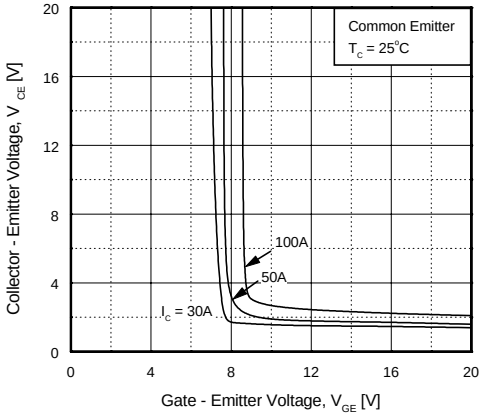

Fig 5. Saturation Voltage vs. V_{GE}

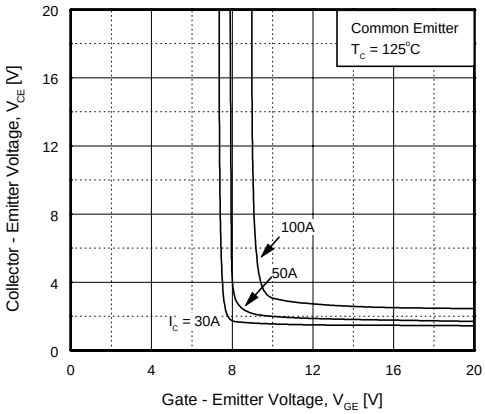

Fig 6. Saturation Voltage vs. V_{GE}

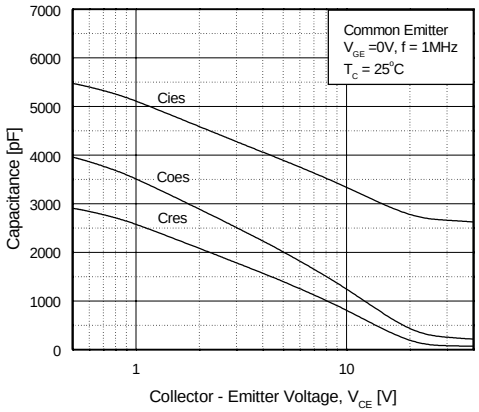

Fig 7. Capacitance Characteristics

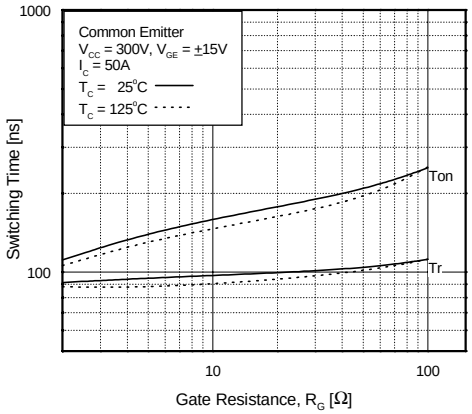

Fig 8. Turn-On Characteristics vs. Gate Resistance

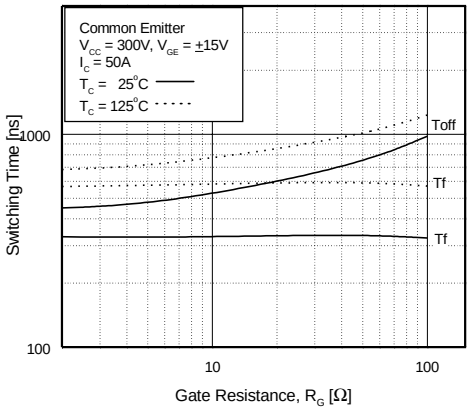

Fig 9. Turn-Off Characteristics vs. Gate Resistance

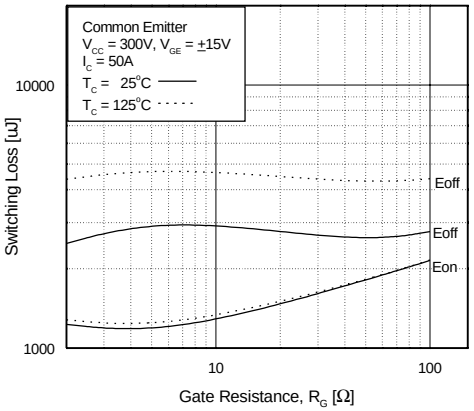

Fig 10. Switching Loss vs. Gate Resistance

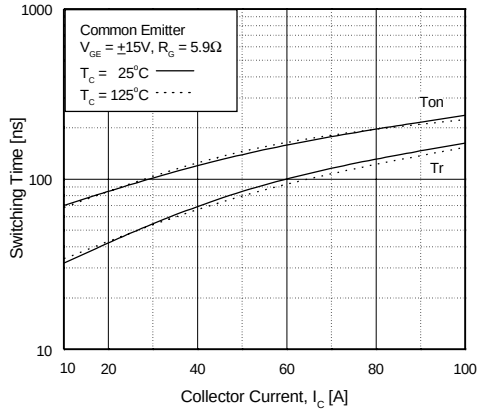

Fig 11. Turn-On Characteristics vs. Collector Current

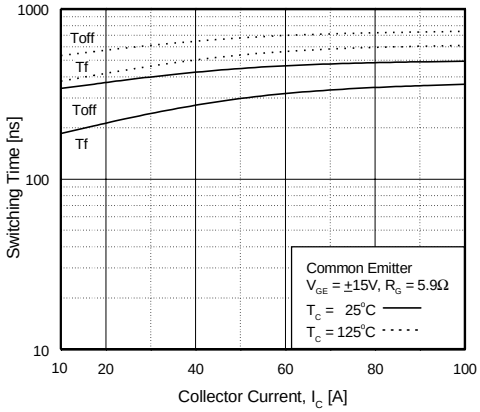

Fig 12. Turn-Off Characteristics vs. Collector Current

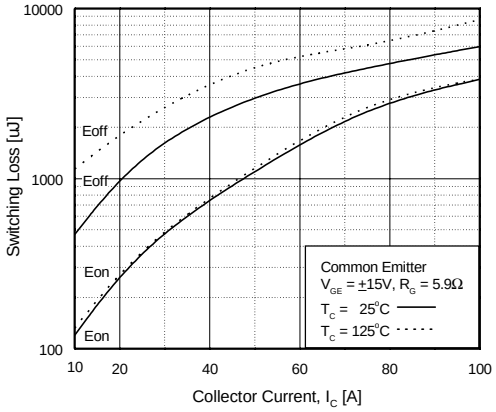

Fig 13. Switching Loss vs. Collector Current

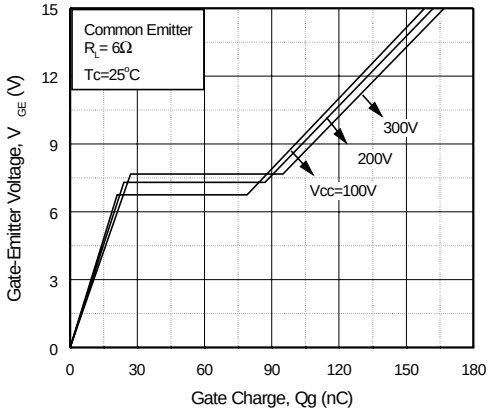

Fig 14. Gate Charge Characteristics

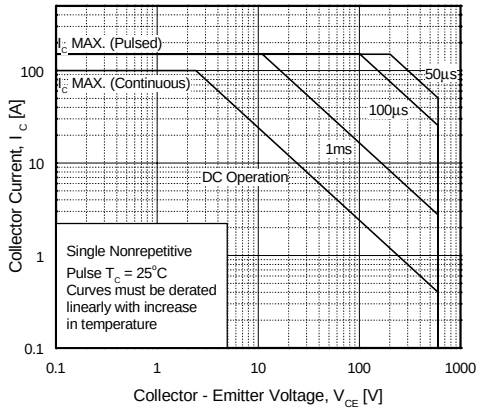

Fig 15. SOA Characteristics

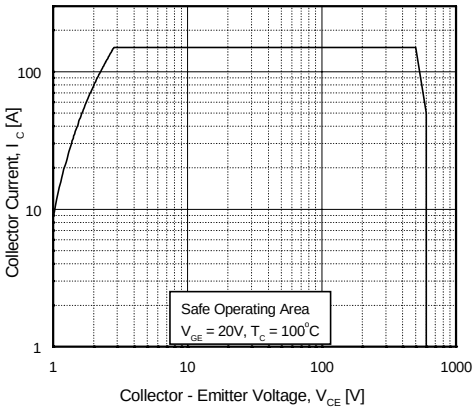

Fig 16. Turn-Off SOA

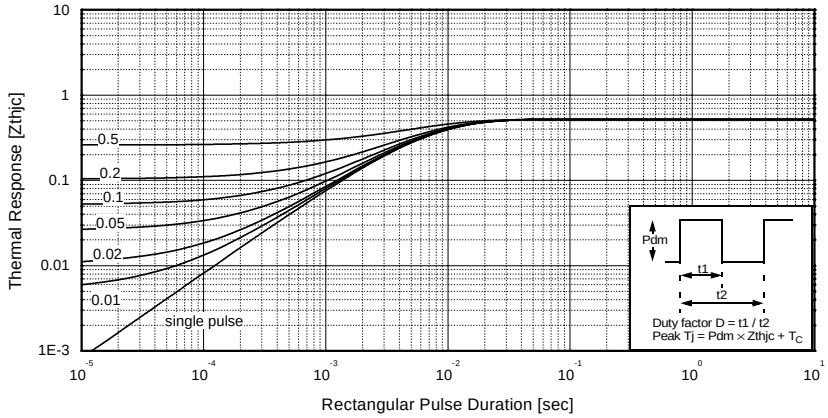

Fig 17. Transient Thermal Impedance of IGBT

Package Dimension

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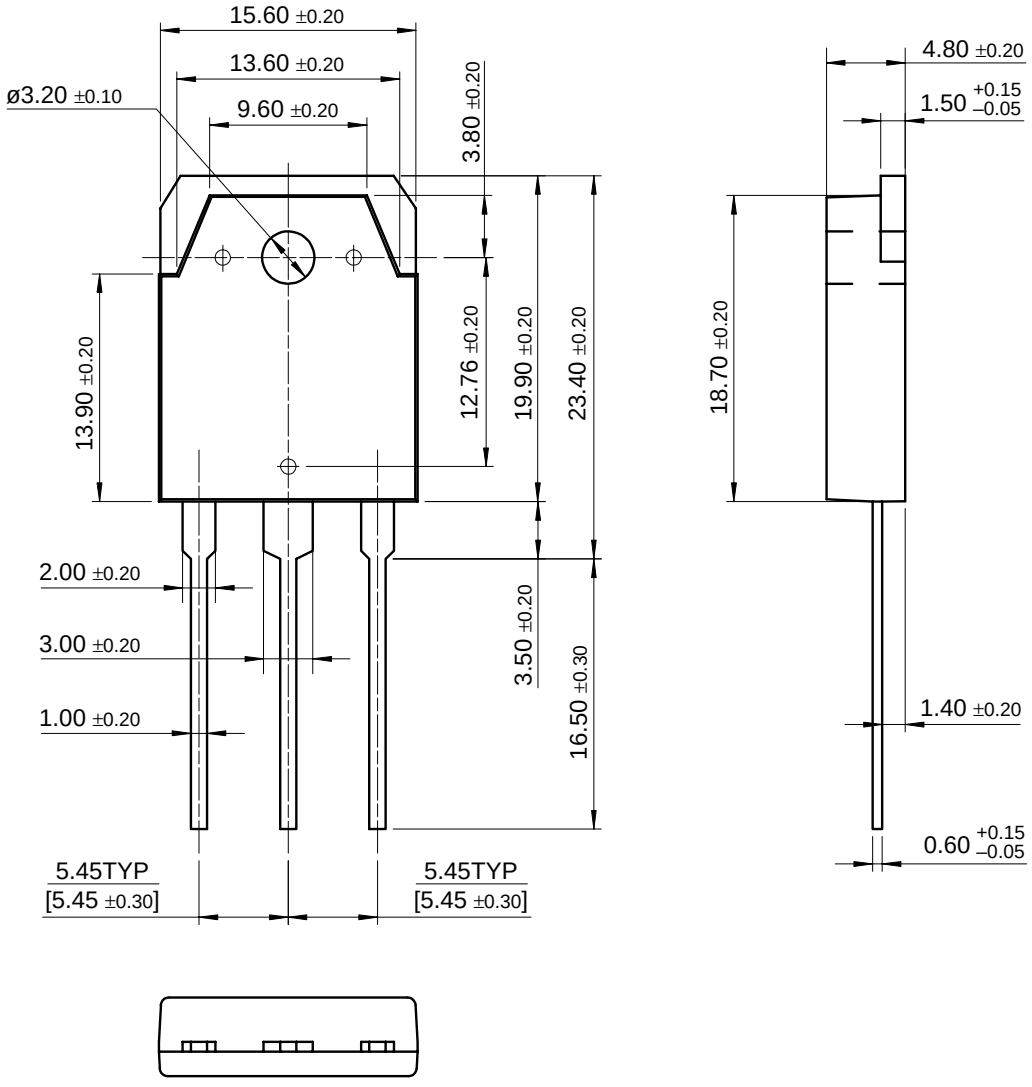

Dimensions in Millimeters

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